

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT  
(Use several sheets if necessary)

(37 CFR 1.98(b))

ATTY. DOCKET  
07977/084001SERIAL NO.  
08/751,365APPLICANT:  
Yamazaki, et al.FILING DATE  
November 18, 1996GROUP  
UnassignedS-68665  
2/29/97  
01/00

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER				ISSUE DATE	PATENTEE		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA										
AB										
AC										
AD										
AE										
AF										
AG										
AH										
AI										
AJ										
AK										

## FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
AL	JL07-43744	7/30/93	Japan				
AM	JL07-72491	2/22/94	Japan				
AN	JL07-120791	10/28/93	Japan				
AO	JL07-134301	11/9/93	Japan				
AP	JL06-160878	9/10/93	Japan				
AQ	JL06-202073	12/28/92	Japan				
AR	JL06-214244	1/14/93	Japan				
AS	JL07-36058	7/20/93	Japan				
AT	JL07-43716	7/28/93	Japan				
AU	JP63-21907	12/25/79	Japan				

## OTHER DOCUMENTS (including Author, Title, Date, Place of Publication)

AV	
AW	
AX	

EXAMINER	<i>T. A.</i>	DATE CONSIDERED	<i>10/14/97</i>
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			

JAN 16 2001

Sheet 1 of 1

Substitute Form PTO-1449  
(Modified)U.S. Department of Commerce  
Patent and Trademark OfficeAttorney's Docket No.  
07977-084002Application No.  
09/686,653Information Disclosure Statement  
by Applicant  
(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant  
Yamazaki et al.Filing Date  
October 10, 2000

Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
TJ	AA	5,270,846	12/93	Watanabe et al.	349	138	
17	AB	5,194,976	3/93	Nakano et al.	349	138	
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

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## Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

## Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature

T.T.

Date Considered

03/21/01

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.